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"High Side Chopper" IGBT SOT-227 (Ultrafast IGBT), 50 A



SOT-227

PRODUCT SUMMARY					
V _{CES}	1200 V				
I _C DC	50 A at 92 °C				
V _{CE(on)} typical at 50 A, 25 °C	3.22 V				
Speed	8 kHz to 30 kHz				
Package	SOT-227				
Circuit	High side switch				

FEATURES

- NPT Gen 5 IGBT technology
- Square RBSOA
- HEXFRED® clamping diode
- Positive V_{CE(on)} temperature coefficient
- · Fully isolated package
- Very low internal inductance (≤ 5 nH typical)
- · Industry standard outline
- UL approved file E78996



• Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

BENEFITS

- · Designed for increased operating efficiency in power conversion: UPS, SMPS, welding, induction heating
- Easy to assemble and parallel
- Direct mounting on heatsink
- Plug-in compatible with other SOT-227 packages
- · Low EMI, requires less snubbing

ABSOLUTE MAXIMUM RATII	NGS				
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS	
Collector to emitter voltage	V _{CES}		1200	V	
Continuous collector current		T _C = 25 °C	84		
Continuous collector current	Ic	T _C = 80 °C	57		
Pulsed collector current	I _{CM}		150	A	
Clamped inductive load current	I _{LM}		150		
Diode continuous forward current		T _C = 25 °C	76		
	l _F	T _C = 80 °C	52		
Gate to emitter voltage	V_{GE}		± 20	V	
Power dissipation, IGBT	P _D	T _C = 25 °C	431		
	FD	T _C = 80 °C	242	w	
Power dissipation, diode	D-	T _C = 25 °C	278] vv	
	P _D	T _C = 80 °C	156		
RMS isolation voltage	V _{ISOL}	Any terminal to case, t = 1 min	2500	V	



ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS	
Collector to emitter breakdown voltage	V _{BR(CES)}	$V_{GE} = 0 \text{ V}, I_C = 1 \text{ mA}$	1200	-	-		
		V _{GE} = 15 V, I _C = 25 A	-	2.46	-		
Callector to amittar valtage	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	V _{GE} = 15 V, I _C = 50 A	-	3.22	2.80	V	
Collector to emitter voltage	V _{CE(on)}	$V_{GE} = 15 \text{ V}, I_{C} = 25 \text{ A}, T_{J} = 125 ^{\circ}\text{C}$	-	2.84	3.60		
		$V_{GE} = 15 \text{ V}, I_{C} = 50 \text{ A}, T_{J} = 125 ^{\circ}\text{C}$	-	3.78	3.0		
Gate threshold voltage	V _{GE(th)}	$V_{CE} = V_{GE}, I_{C} = 500 \mu A$	4	5	4		
Temperature coefficient of threshold voltage	V _{GE(th)} /ΔT _J	V _{CE} = V _{GE} , I _C = 1 mA (25 °C to 125 °C)	-	-10	-	mV/°C	
Callector to amittar leakers arranged		V _{GE} = 0 V, V _{CE} = 1200 V	-	6	50	μΑ	
Collector to emitter leakage current	I _{CES}	V _{GE} = 0 V, V _{CE} = 1200 V, T _J = 125 °C	-	0.7	2.0	mA	
Diode reverse breakdown voltage	V_{BR}	I _R = 1 mA	1200	-	-	V	
Diode forward voltage drop		I _C = 25 A, V _{GE} = 0 V	-	1.99	2.42	V	
	V _{FM}	I _C = 50 A, V _{GE} = 0 V	-	2.53	3.00		
		I _C = 25 A, V _{GE} = 0 V, T _J = 125 °C	-	1.96	2.30		
		I _C = 50 A, V _{GE} = 0 V, T _J = 125 °C	-	2.66	3.08		
Disability of the second		V _R = V _R rated	-	4	50	μA	
Diode reverse leakage current I _{RM}		T _J = 125 °C, V _R = V _R rated	-	0.6	3	mA	
Gate to emitter leakage current	I _{GES}	V _{GE} = ± 20 V	-	-	± 200	nA	

SWITCHING CHARACTERISTICS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNITS
Total gate charge (turn-on)	Q_g			-	400	-	
Gate to emitter charge (turn-on)	Q _{ge}	I _C = 50 A, V _{CC} = 600 V, V _{GE} = 15 V		-	43	-	nC
Gate to collector charge (turn-on)	Q _{gc}					-	1
Turn-on switching loss	E _{on}	I _C = 50 A, V _{CC} = 600 V,		-	2.72	-	
Turn-off switching loss	E _{off}	$V_{GE} = 15 \text{ V}, R_g = 5 \Omega,$		-	1.11	-	mJ
Total switching loss	E _{tot}	L = 500 µH, T _J = 25 °C		-	3.83	-	
Turn-on switching loss	E _{on}		Energy losses include tail and diode recovery (see fig. 18)	-	3.94	-	
Turn-off switching loss	E _{off}	I _C = 50 A, V _{CC} = 600 V,		-	2.31	-	
Total switching loss	E _{tot}			-	6.25	-	
Turn-on delay time	t _{d(on)}	$V_{GE} = 15 \text{ V}, R_g = 5 \Omega,$		-	191	-	ns
Rise time	t _r	$L = 500 \mu H, T_J = 125 °C$		-	53	-	
Turn-off delay time	t _{d(off)}			-	223	-	
Fall time	t _f			-	143	-]
Reverse bias safe operating area	RBSOA	T_J = 150 °C, I_C = 150 A, R_g = 22 Ω , V_{GE} = 15 V to 0 V, V_{CC} = 900 V, V_P = 1200 V			Fullsquare		
Diode reverse recovery time	t _{rr}			-	129	161	ns
Diode peak reverse current	I _{rr}	$I_F = 50$ A, $dI_F/dt = 200$ A/ μ s, $V_R = 200$ V - 11 14 - 700 1046				14	Α
Diode recovery charge	Q _{rr}					1046	nC
Diode reverse recovery time	t _{rr}					257	ns
Diode peak reverse current	I _{rr}	I _F = 50 A, dI _F /dt = 200 A/μs, V _B = 200 V, T _J = 125 °C			17	21	Α
Diode recovery charge	Q _{rr}	v _R - 200 v, 1j = 123 O	-	1768	2698	nC	



THERMAL AND MECHANICAL SPECIFICATIONS							
PARAMETER		SYMBOL		MIN.	TYP.	MAX.	UNITS
Junction and storage temperature range	Э	T _J , T _{Stg}		-40	-	150	°C
Junction to case	IGBT	R _{thJC}		-	-	0.29	
Junction to case	Diode			-	-	0.45	°C/W
Case to heatsink		R _{thCS}	Flat, greased surface	-	0.05	-	
Weight				-	30	-	g
Mounting torque				-	-	1.3	Nm
Case style		SOT-227					

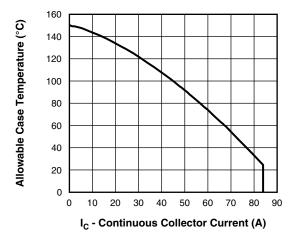


Fig. 1 - Maximum DC IGBT Collector Current vs. Case Temperature

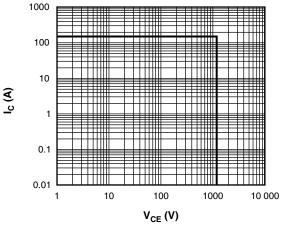


Fig. 2 - IGBT Reverse Bias SOA $T_J = 150$ °C, $V_{GE} = 15$ V

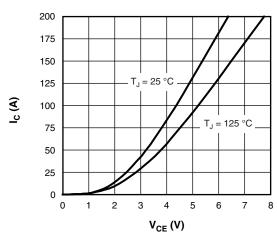


Fig. 3 - Typical IGBT Collector Current Characteristics

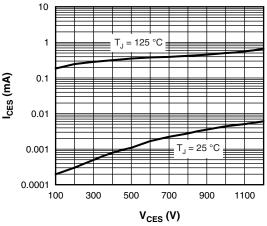


Fig. 4 - Typical IGBT Zero Gate Voltage Collector Current



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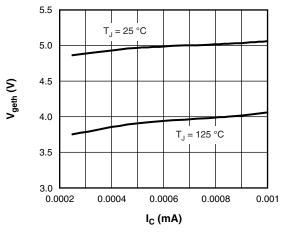


Fig. 5 - Typical IGBT Threshold Voltage

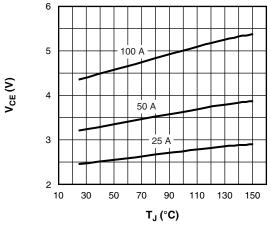


Fig. 6 - Typical IGBT Collector to Emitter Voltage vs. Junction Temperature, $V_{GE} = 15 \text{ V}$

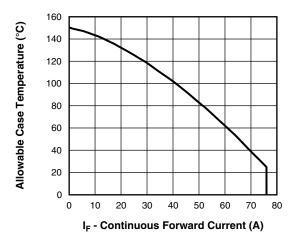


Fig. 7 - Maximum DC Forward Current vs.
Case Temperature

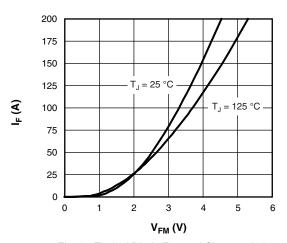


Fig. 8 - Typical Diode Forward Characteristics

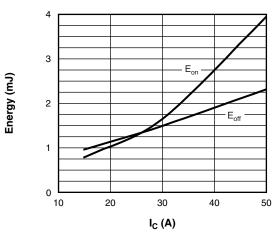


Fig. 9 - Typical IGBT Energy Loss vs. I_C T_J = 125 °C, L = 500 μ H, V_{CC} = 600 V, R_g = 5 Ω , V_{GE} = 15 V

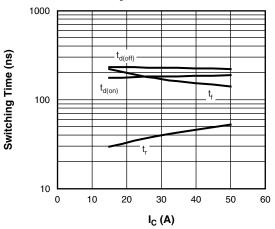


Fig. 10 - Typical IGBT Switching Time vs. I_C T_J = 125 °C, L = 500 μ H, V_{CC} = 600 V, R_g = 5 Ω , V_{GE} = 15 V





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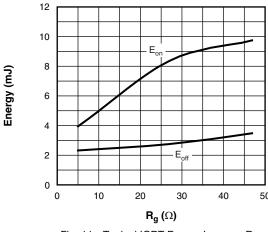


Fig. 11 - Typical IGBT Energy Loss vs. R_g T_J = 125 °C, I_C = 50 A, L = 500 μ H, V_{CC} = 600 V, V_{GE} = 15 V

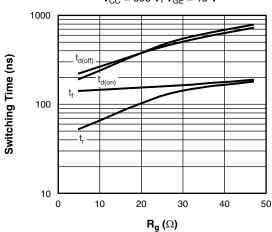


Fig. 12 - Typical IGBT Switching Time vs. R_g $T_J = 125$ °C, $L = 500~\mu H, V_{CC} = 600~V,$ $I_C = 50~A, V_{GE} = 15~V$

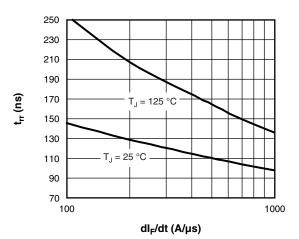


Fig. 13 - Typical t_{rr} Diode vs. dI_F/dt $V_R = 200 \text{ V}, I_F = 50 \text{ A}$

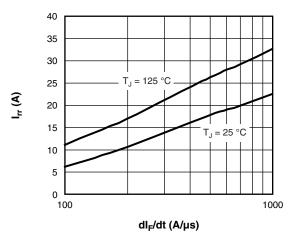


Fig. 14 - Typical I_{rr} Diode vs. dI_F/dt $V_R = 200 \text{ V}$, $I_F = 50 \text{ A}$

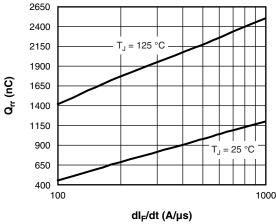


Fig. 15 - Typical Q_{rr} Diode vs. dI_F/dt , $V_R = 200 \text{ V}$, $I_F = 50 \text{ A}$

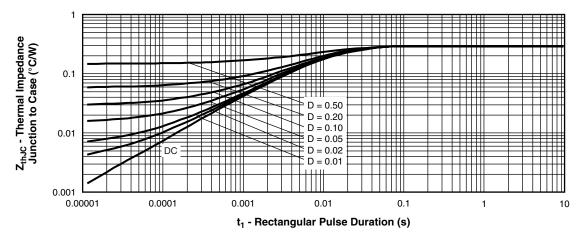


Fig. 16 - Maximum Thermal Impedance ZthJC Characteristics (IGBT)

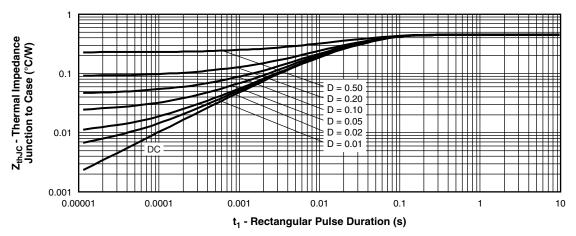
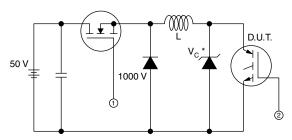


Fig. 17 - Maximum Thermal Impedance Z_{thJC} Characteristics (Diode)



- * Driver same type as D.U.T.; V_C = 80 % of $V_{\rm ce(max)}$ * Note: Due to the 50 V power supply, pulse width and inductor will increase to obtain Id

Fig. 18a - Clamped Inductive Load Test Circuit

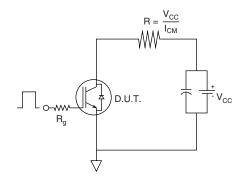


Fig. 18b - Pulsed Collector Current Test Circuit

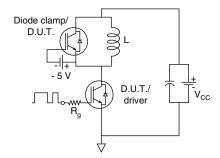


Fig. 19a - Switching Loss Test Circuit

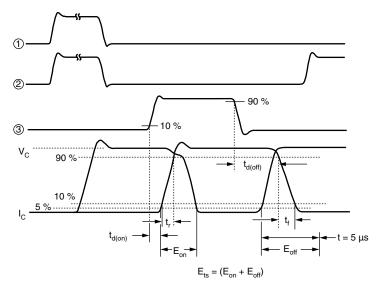
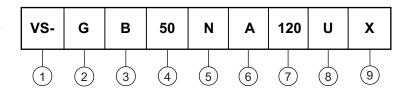


Fig. 19b - Switching Loss Waveforms Test Circuit

ORDERING INFORMATION TABLE

Device code



1 - Vishay Semiconductors product

- Insulated Gate Bipolar Transistor (IGBT)

3 - B = IGBT Generation 5

Current rating (50 = 50 A)

- Circuit configuration (N = High side chopper)

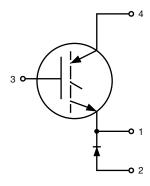
Package indicator (A = SOT-227)

7 - Voltage rating (120 = 1200 V)

Speed/type (U = Ultrafast IGBT)

9 - X = F/W HEXFRED® diode

CIRCUIT CONFIGURATION

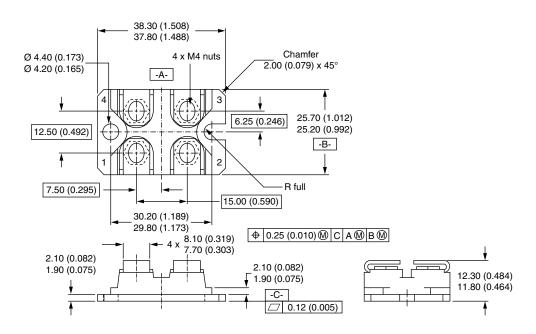


LINKS TO RELATED DOCUMENTS					
Dimensions <u>www.vishay.com/doc?95036</u>					
Packaging information	www.vishay.com/doc?95037				



SOT-227

DIMENSIONS in millimeters (inches)



Notes

- Dimensioning and tolerancing per ANSI Y14.5M-1982
- · Controlling dimension: millimeter

Document Number: 95036 Revision: 28-Aug-07



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